

# Search Notes



Application/Control No.

10/730,634

Examiner

Anh Q. Tran

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2819

## SEARCHED

Class	Subclass	Date	Examiner
326	82 83 84	3/16/05	AT
	90		
365	189.01		
	189.03		
	189.04		
	189.06		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR